



# High Performance Grating-Outcoupled Surface Emitting(GSE) Lasers Using Quantum Well Intermixing

Update 6/25/04

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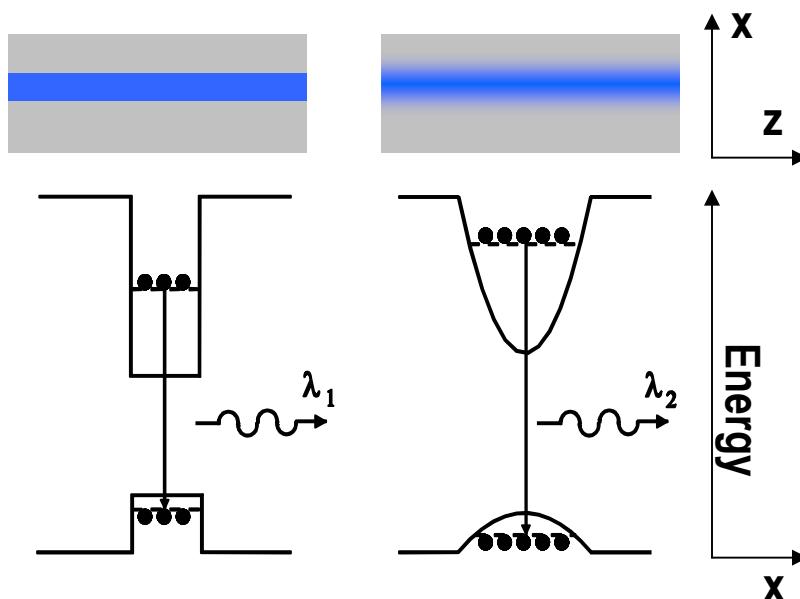
June 25<sup>th</sup>, 2004



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A Collaboration with Photodigm Inc. and Agilent Technologies

## Quantum Well Intermixing (QWI)



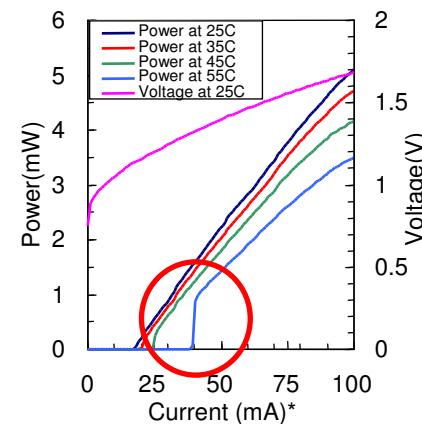
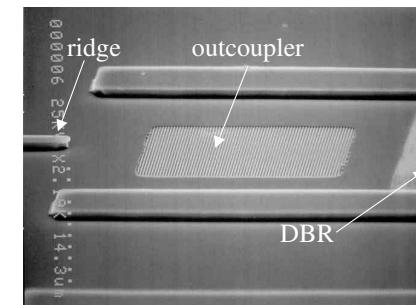
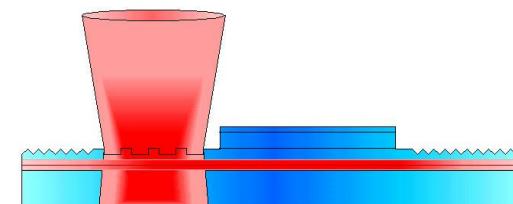
- **Applications:**
  - Multi-wavelength laser arrays
  - Quantum well lasers
  - Waveguide demultiplexer
  - Photodetectors
  - Modulators
- **Our Interests**
  - GSE lasers
  - Multi-wavelength cross-grating GSE lasers



## Grating-outcoupled Surface Emitting (GSE) lasers

- 1<sup>st</sup> order feedback grating + 2<sup>nd</sup> order outcoupler grating
- Problem: “snap-on” behavior at high temperature due to a combination of low DBR reflectivity and the saturated absorption of the quantum wells in the passive DBR and outcoupler regions.
- Solutions:
  - Increasing DBR reflectivity
  - Quantum Well Intermixing in passive DBR and outcoupler sections
- Perspective:
  - Lower threshold (10 mA)
  - Higher slope efficiency (0.2 W/A)
  - Higher temperature operation (>100C)
  - Higher modulation speed (> 5 Gbps)
  - No “snap-on” behavior

\* Data provided by Photodigm Inc.

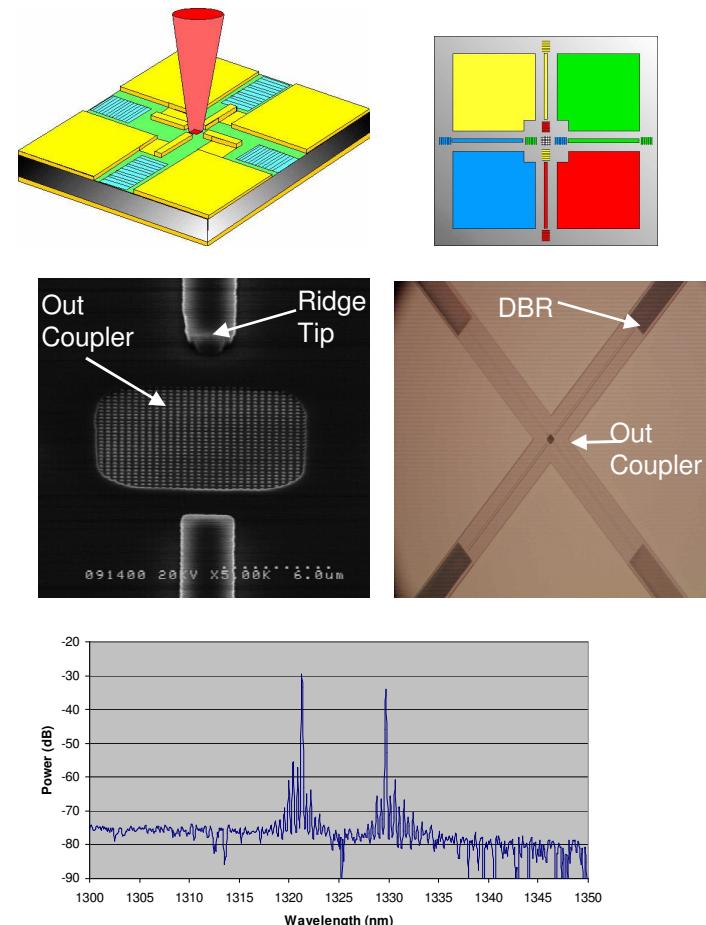


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# Multi-Wavelength Cross-Grating GSE Lasers

- Monolithic multi-wavelength optical sources:
  - WDM: 0.8 nm spacing
  - CWDM: 20 nm spacing
- Current 2-wavelength Cross Grating GSE:
  - 8 nm spacing
  - > 0.5 mW output power
- Using QWI:
  - Higher power, lower threshold
  - 20 nm spacing for CWDM application
- Future goal: 4 wavelengths emitting from one single aperture
  - Cover 80 nm wavelength range

\* Data provided by Photodigm Inc.



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## Research Plan

### Phase I

- Experiment ion implantation approach to develop processes of selective intermixing without severe PL intensity saturation.
- Fabricate ridge waveguide lasers from the GSE wafer structure using QWI.

### Phase II

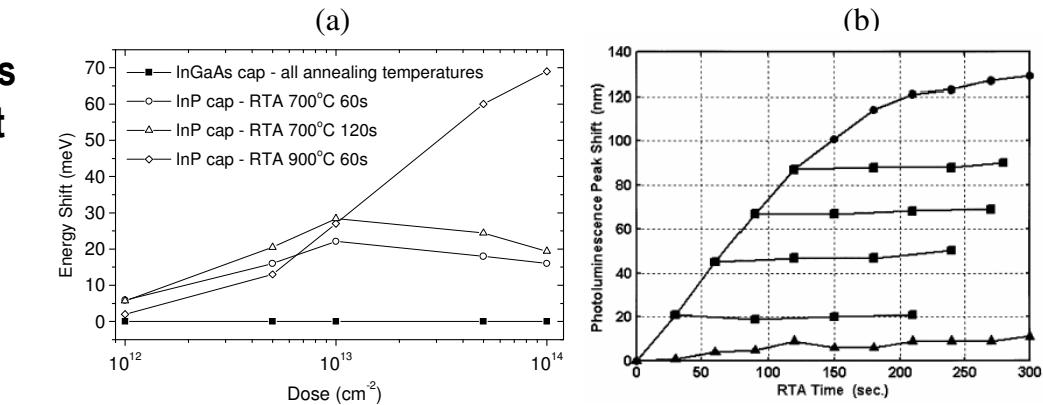
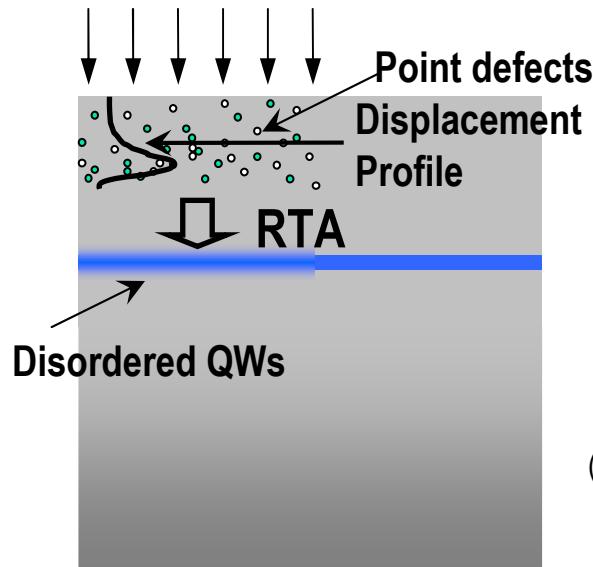
- Develop QWI processes for GSE lasers to improve their performances.
- Investigate the reproducibility of the processes.

### Phase III

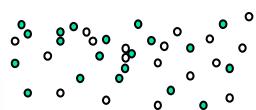
- Apply QWI to the active regions of GSE lasers to modify the lasing wavelengths.
- Develop GSE Laser arrays with multiple lasing wavelengths using QWI.



## QWI by Ion Implantation

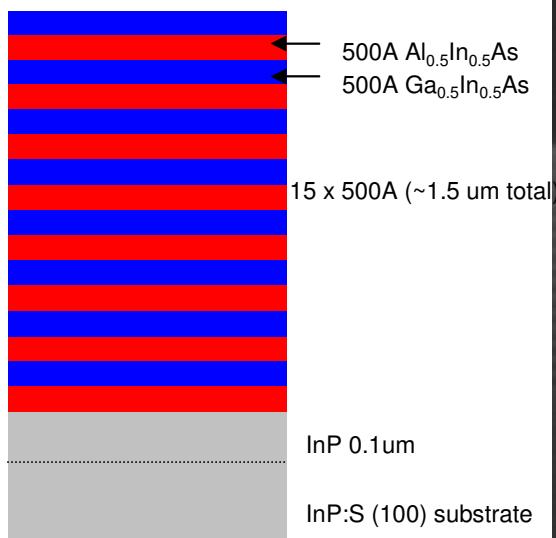


- (a) Energy shifts of InGaAs/AlGaInAs quantum wells as a function of dose for 20 keV P ion cap implants at 25C for different annealing temperatures and cap layers.  
(Carmody (2003), Defect Engineering of InP and InGaAs for Optoelectronic Applications, PhD thesis, Canberra, Australian National University)
- (b) PL wavelength peak shift as a function of anneal time for InGaAsP MQW. (Skogen et al., Journal of Quantum Electronics, Vol. 9, No. 5,p1183 – 1190 (2003))

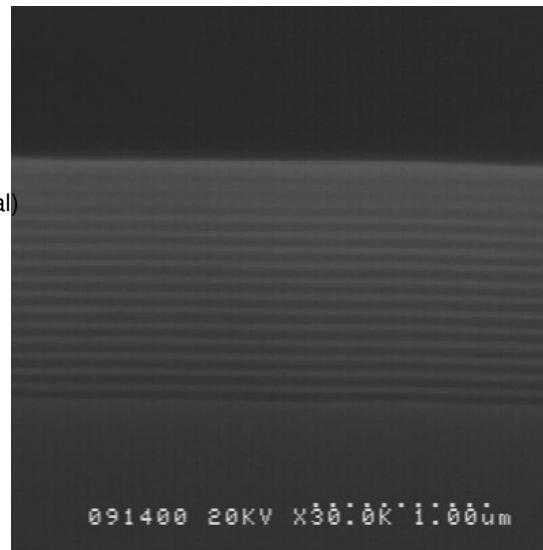


## QWI Experiment Results (1)

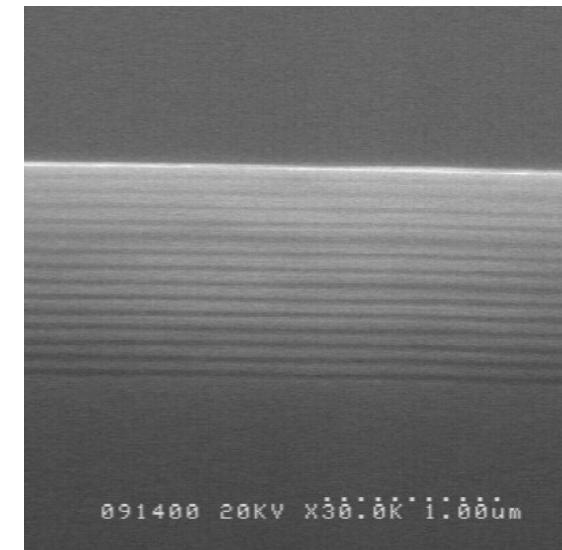
Super Lattice Structure



SEM picture before RTA



SEM picture after RTA at 700 C for 10 mins



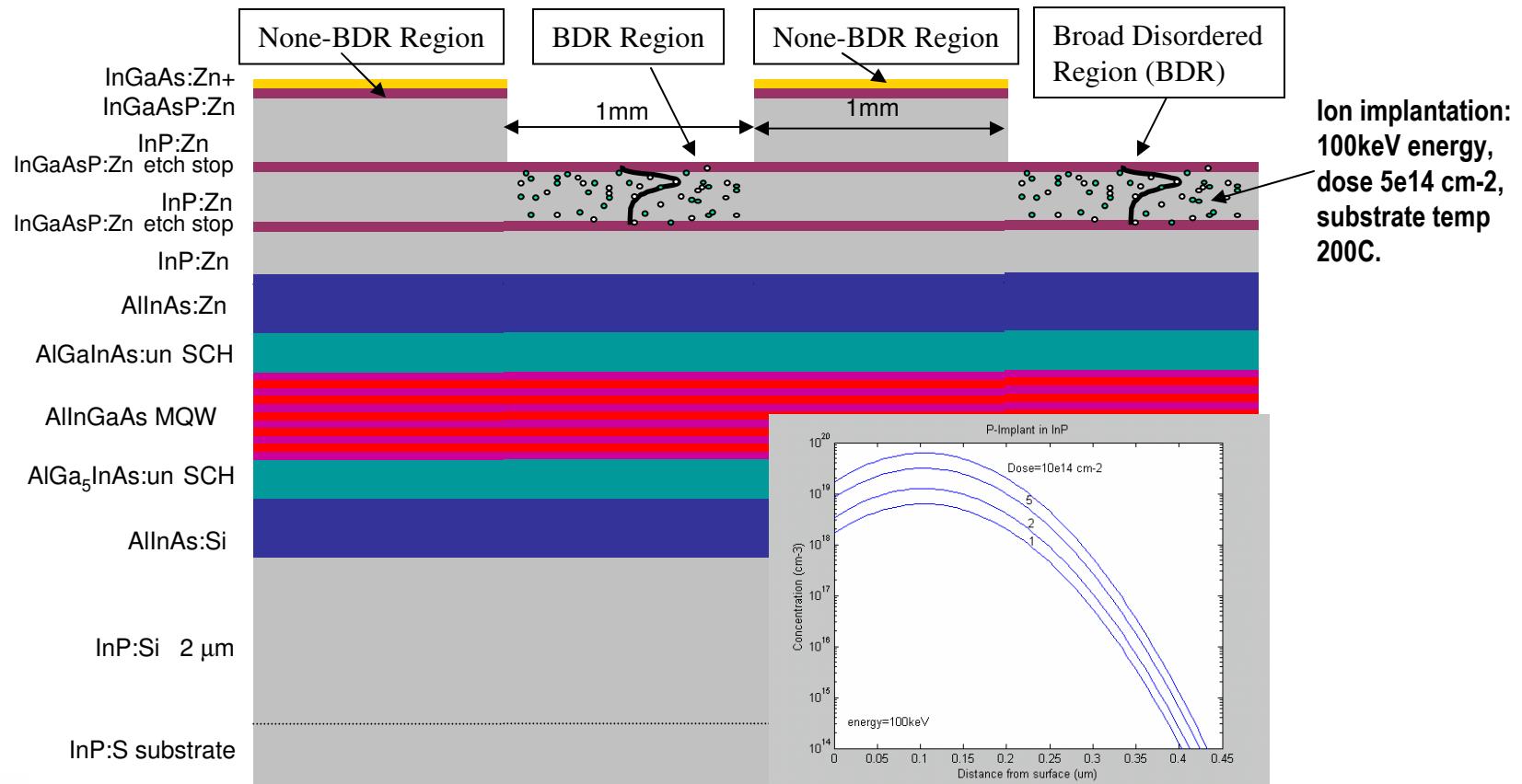
OMLW 2572 A-A (AllnAs on surface)



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# Wafer Structures for QWI Experiments (2)

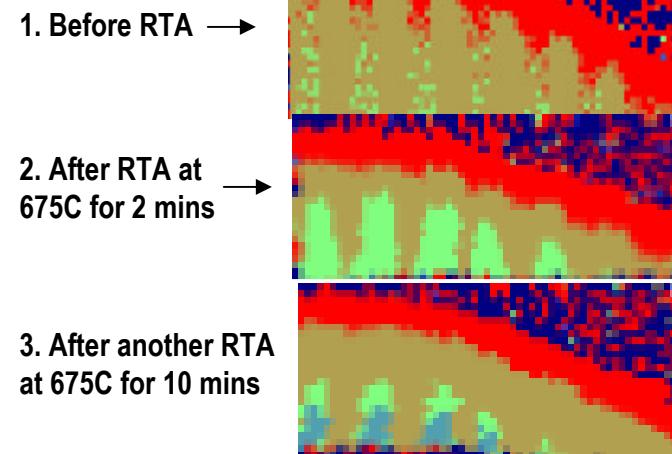


# Summary of Experimental Data

Summary of wavelength shifts of wafer 2709B-A  
after QWI

RTA @ 675C Time	Wavelength shift (nm) in <b>BDR</b> (broad disorder region) (Total 9 channels)				
	7-1	7-2	7-3	7-4	8-1
2min	8.6	8.6	8.6	8.6	8.6
10 min	8.5	8.5	8.5	8.5	0
Total shift for 12 mins	17.1	17.1	17.1	17.1	8.6

PL Spectrum Maps of 2709B-A



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